

TESTING CENTRE TE	TEST REPORT		
FCC ID:			
	2BLV5-22X02		
Test Report No::	TCT240919E024		
Date of issue::	Oct. 23, 2024		
Testing laboratory:	SHENZHEN TONGCE TESTING LAB		
Testing location/ address:	2101 & 2201, Zhenchang Factory, Renshan Industrial Zone, Fuhai Subdistrict, Bao'an District, Shenzhen, Guangdong, 518103, People's Republic of China		
Applicant's name::	LOCOSYS Technology Inc.		
Address::	20F13, No.79, Sec. 1, Xintai 5th Rd., Xizhi Dist., New Taipei City 22101, Taiwan		
Manufacturer's name:	OCOSYS Technology Inc.		
Address:	20F13, No.79, Sec. 1, Xintai 5th Rd., Xizhi Dist., New Taipei City 22101, Taiwan		
Standard(s)::	FCC CFR Title 47 Part 2 FCC CFR Title 47 Part22 FCC CFR Title 47 Part24 FCC CFR Title 47 Part27 FCC CFR Title 47 Part90		
Product Name::	RTK Base Station		
Trade Mark:	LOCOSYS		
Model/Type reference:	GB-104B, GB-10WB, GB-30WB, GB-34WB		
Rating(s)::	Rechargeable Li-ion Battery DC 3.7V		
Date of receipt of test item:	Sep. 19, 2024		
Date (s) of performance of test:	Sep. 19, 2024 ~ Oct. 23, 2024		
Tested by (+signature):	Rieo LIU		
Check by (+signature):	Beryl ZHAO Roy(TCT)		
Approved by (+signature):	Tomsin		

General disclaimer:

This report shall not be reproduced except in full, without the written approval of SHENZHEN TONGCE TESTING LAB. This document may be altered or revised by SHENZHEN TONGCE TESTING LAB personnel only, and shall be noted in the revision section of the document. The test results in the report only apply to the tested sample.



TABLE OF CONTENTS

1. General Product Information	3
1.1. EUT description	
1.2. Model(s) list	3
1.3. Emission Designator	4
1.4. Test Frequency	4
2. Test Result Summary	6
3. General Information	7
3.1. Test environment and mode	7
3.2. Description of Support Units	9
3.3. Configuration of Tested System	
3.4. Measurement Results Explanation Example	9
4. Facilities and Accreditations	
4.1. Facilities	10
4.2. Location	10
4.3. Measurement Uncertainty	10
5. Test Results and Measurement Data	11
5.1. Effective Radiated Power and Effective Isotropic Radiated Power Measurement	.,11
5.2. Peak to Average Ratio	13
5.3. 99% Occupied Bandwidth and 26dB Bandwidth Measurement	14
5.4. Band Edge and Conducted Spurious Emission Measurement	15
5.5. Field Strength of Spurious Radiation Measurement	17
5.6. Frequency Stability Measurement	27
Appendix B: Photographs of Test Setup	
Appendix C: Photographs of EUT	
Test Data: Refer to Appendix For LTE Band 5, Appendix For LTE Band 41	and 7



1. General Product Information

1.1. EUT description

Product Name:	RTK Base Station	
Model/Type reference:	GB-104B	
Sample Number:	TCT240919E022-0101	
Tx Frequency:	LTE Band 5: 824 MHz ~ 849 MHz LTE Band 7: 2500 MHz ~ 2570 MHz LTE Band 41: 2496 MHz ~ 2690 MHz	
Rx Frequency:	LTE Band 5: 869 MHz ~ 894 MHz LTE Band 7: 2620 MHz ~ 2690 MHz LTE Band 41: 2496 MHz ~ 2690 MHz	
Bandwidth::	LTE Band 5: 1.4MHz /3MHz /5MHz /10MHz LTE Band 7: 5MHz /10MHz /15MHz /20MHz LTE Band 41: 5MHz /10MHz /15MHz /20MHz	
Maximum Output Power to Antenna:	LTE Band 5: 24.22dBm LTE Band 7: 23.95dBm LTE Band 41: 23.52dBm	
99% Occupied Bandwidth:	LTE Band 5: 8M94G7D LTE Band 7: 18M1G7D LTE Band 41: 18M1G7D	
Type of Modulation:	QPSK/16QAM	
Antenna Type:	PIFA Antenna	
Antenna Gain:	LTE Band 5: -1.89dBi LTE Band 7: 0.16dBi LTE Band 41: 0.16dBi	
Rating(s):	Rechargeable Li-ion Battery DC 3.7V	

Note: The antenna gain listed in this report is provided by applicant, and the test laboratory is not responsible for this parameter.

1.2. Model(s) list

No.	Model No.	Tested with
1	GB-104B	\boxtimes
Other models	GB-10WB, GB-30WB, GB-34WB	

Note: GB-104B is tested model, other models are derivative models. The models are identical in circuit and PCB layout, only different on the model names. So the test data of GB-104B can represent the remaining models.

Page 3 of 29



1.3. Emission Designator

LTE Band 5	QPSK		QPSK 16QAM		АМ
BW(MHz)	Emission Designator (99%OBW)	Maximum ERP(W)	Emission Designator (99%OBW)	Maximum ERP(W)	
1.4	1M09G7D	0.104	1M09W7D	0.085	
3	2M73G7D	0.104	2M73W7D	0.090	
5	4M49G7D	0.098	4M49W7D	0.084	
10	8M94G7D	0.101	8M94W7D	0.088	

LTE Band 7	QPSK		16Q	АМ
BW(MHz)	Emission Designator (99%OBW)	Maximum EIRP(W)	Emission Designator (99%OBW)	Maximum EIRP(W)
5	4M47G7D	0.179	4M47W7D	0.155
10	8M94G7D	0.219	8M93W7D	0.190
15	13M5G7D	0.258		
20	18M1G7D	0.245		(0)

LTE Band 41	QPSK		16Q	АМ
BW(MHz)	Emission Designator (99%OBW)	Maximum EIRP(W)	Emission Designator (99%OBW)	Maximum EIRP(W)
5	4M47G7D	0.223	4M47W7D	0.185
10	8M94G7D	0.222	8M94W7D	0.188
15	13M5G7D	0.233		
20	18M1G7D	0.198		





1.4. Test Frequency

4		_ 4	F	
			TESTING CENTRE TECHNOLOGY	Report No.: TCT240919E024
	_		7 77 77 1 77 77	

LTE Band 5(1.4MHz)		LTE Band	d 5(3MHz)	
Channel	Frequency (MHz)	Channel	Frequency (MHz)	
20407	824.7	20415	825.5	
20525	836.5	20525	836.5	
20643	848.3	20635	847.5	
LTE Band	5(5MHz)	LTE Band 5(10MHz)		
Channel	Frequency (MHz)	Channel	Frequency (MHz)	
20425	826.5	20450	829	
20525	836.5	20525	836.5	
20625	846.5	20600	844	

LTE Band	7(5MHz)	LTE Band	d 7(10MHz)
Channel	Frequency (MHz)	Channel	Frequency (MHz)
20775	2502.5	20800	2505
21100	2535	21100	2535
21425	2567.5	21400	2565
LTE Band	7(15MHz)	LTE Band	d 7(20MHz)
Channel	Frequency (MHz)	Channel	Frequency (MHz)
20825	2507.5	20850	2510
21100	2535	21100	2535
21375	2562.5	21350	2560
(C)	(0)	(20)	(,0,)

41(5MHz)	LIE Ban	nd 41(10MHz)
Frequency (MHz)	Channel	Frequency (MHz)
2537.5	40090	2540
2605	40740	2605
2672.5	41390	2670
41(15MHz)	LTE Band 41(20MHz)	
Frequency (MHz)	Channel	Frequency (MHz)
2542.5	40140	2545
2605	40740	2605
2667.5	41340	2665
	2537.5 2605 2672.5 41(15MHz) Frequency (MHz) 2542.5 2605	2537.5 40090 2605 40740 2672.5 41390 41(15MHz) LTE Ban Frequency (MHz) Channel 2542.5 40140 2605 40740



2. Test Result Summary

Requirement	CFR 47 Section	Result
Conducted Output Power	§2.1046; §22.913; §24.232(c); §27.50(d); §27.50(c); §27.50(b); §90.542(a)	PASS
Peak-to-Average Ratio	§2.1046; §24.232(d) §27.50(d); §27.50(c); §27.50(b)	PASS
Effective Radiated Power	§2.1046; §22.913; §24.232(c); §27.50(d); §27.50(c); §27.50(b); §90.542(a)	PASS
Equivalent Isotropic Radiated Power	§2.1046; §22.913; §24.232(c); §27.50(d); §27.50(c); §27.50(b); §90.542(a)	PASS
Occupied Bandwidth	\$2.1049; §24.238(b); §27.53; §90.209(a) §2.1051; §22.917(a);	
Band Edge		
Conducted Spurious Emission	§2.1051; §22.917(a); §27.53(h); §27.53(g); §27.53(c); §24.238(a); §90.543(c)	PASS
Field Strength of Spurious Radiation	§2.1053; §22.917(a); §27.53(g); §27.53(c); §27.53(h); §24.238(a); §90.543(c)	PASS
Frequency Stability for Temperature & Voltage	§2.1055; §22.355; §27.54; §24.235; §90.213	PASS

Note:

- 1. PASS: Test item meets the requirement.
- 2. Fail: Test item does not meet the requirement.
- 3. N/A: Test case does not apply to the test object.
- 4. The test result judgment is decided by the limit of test standard.

Page 6 of 29



TESTING CENTRE TECHNOLOGY Report No.: TCT240919E024

3. General Information

3.1. Test environment and mode

Operating Environment:									
Temperature:	25.0 °C								
Humidity:	56 % RH								
Atmospheric Pressure:	1010 mbar								

Keep the EUT in communication with CMW500 and select channel with modulation All modes and data rates and positions were investigated.

Test modes are chosen to be reported as the worst case configuration below:

Test Mode							
	Band Radiated TCs Conducted TCs						
	LTE Band 5	QPSK Link (1.4MHz / 3MHz / 5MHz / 10MHz)	16QAM Link (1.4MHz / 3MHz / 5MHz / 10MHz)				
	LTE Band 7	QPSK Link (5MHz / 10MHz / 15MHz / 20MHz)	16QAM Link (5MHz / 10MHz)				
	LTE Band 41	QPSK Link (5MHz / 10MHz / 15MHz / 20MHz)	16QAM Link (5MHz / 10MHz)				

Antenna port conducted and radiated test items were performed according to KDB 971168 D01 Power Meas License Digital Systems v03 with maximum output power. Radiated measurements were performed with rotating EUT in different three orthogonal test planes to find the maximum emission. The sample was placed 0.8m/1.5m above the ground plane of 3m chamber. Measurements in both horizontal and vertical polarities were performed. During the test, each emission was maximized by: having the EUT continuously working, investigated all operating modes, rotated about all 3 axis (X, Y & Z) and considered typical configuration to obtain worst position, manipulating interconnecting cables, rotating the turntable, varying antenna height from 1m to 4m in both horizontal and vertical polarization. The emissions worst-case are shown in Test Results of the following pages.

Page 7 of 29



Took Karra	David		В	andwi	dth (MH	lz)		Mod	ulation		RB#		Tes	t Chan	inel
Test Items	Band	1.4	3	5	10	15	20	QPSK	16QAM	1	Half	Full	L	М	Н
	5	V	v	v	v	-	<u> </u>	v	v	V	v	v	v	v	V
Max. Output Power	7		-	v	v	V	v	v	v	V	v	v	v	٧	V
	41	-	ı	v	v	v	V	v	٧	v	v	V	٧	v	V
Peak-to-Average	5	^	٧	V	v	-	-	v	v	v	-		v	v	\
Ratio	7	-	ı	٧	V	v	v	٧	v	v	-) v	v	\
	41	-	ı	v	v	v	v	v	v	v	-	-	v	v	\
26dB and 99%	5	V	v	v	v	-	77	v	v		-	v	v	V	V
Bandwidth	7		-	v	v	٧	V	v	v		/ -	v	v	٧	
	41	-	•	v	v	v	v	v	v	-	-	v	v	v	٧
	5	v	٧	V	v	-	-	V	v	-	-	V	v	-	٧
Conducted Band Edge	7	-	•	٧	V	v	v	V	v	-	-	V	V	-	\
	41	-	•	v	v	v	v	v	v	-	-	v	v	-	٧
	5	V	v	v	v	-	7.7	v	v		-	v	v	V	V
Conducted Spurious Emission	7	(2)	/ -	v	v	V	V	v	v	6	/ -	v	v	V	V
	41	-	-	v	v	v	v	v	v	-	-	v	v	v	V
	5	-	-		v	-	-	V	v	-	-	v	v	v	V
Frequency Stability	7	-	-	6)-	-	v	v) -	-	-	v	v	v	v
	41	-	•	-	-	-	v	v	-	-	-	v	v	v	v
	5	V	v	v	v	-	X 1	v	v	V	v	v	v	V	V
E.R.P./ E.I.R.P.	7		<i>)</i> -	v	v	V	y	v	v	V	V	v	V	V	V
	41	-	•	v	v	v	v	v	v	v	v	v	V	v	٧
	5	-	-		v	-	-	V	v	v	-		V	v	١
Radiated Spurious Emission	7	-	•	V)- -	-	-	V	V	v	-		v	v	V
	41	-	-	-	-	-	v	v	v	v	-	-	v	v	v





3.2. Description of Support Units

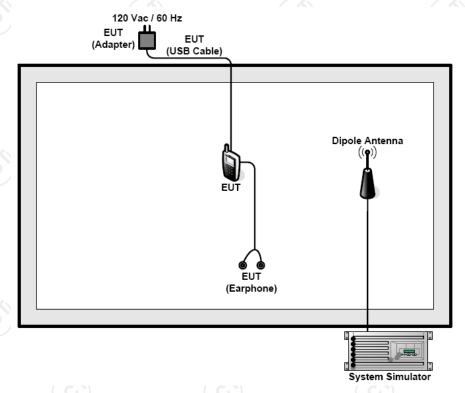
The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

Equipment	Model No.	Serial No.	FCC ID	Trade Name
	1 (0)	1 (3)	/	(6) 1

Note:

- 1. All the equipment/cables were placed in the worst-case configuration to maximize the emission during the test.
- 2. Grounding was established in accordance with the manufacturer's requirements and conditions for the intended use.

3.3. Configuration of Tested System



3.4. Measurement Results Explanation Example

For all conducted test items:

The offset level is set in the spectrum analyzer to compensate the RF cable loss and attenuator factor between RF conducted output port and spectrum analyzer. With the offset compensation, the spectrum analyzer reading level will be exactly the RF output level. The spectrum analyzer offset is derived from RF cable loss and attenuator factor. $Offset = RF \ cable \ loss + attenuator \ factor.$

Page 9 of 29



4. Facilities and Accreditations

4.1. Facilities

The test facility is recognized, certified, or accredited by the following organizations:

• FCC - Registration No.: 645098

SHENZHEN TONGCE TESTING LAB

Designation Number: CN1205

The testing lab has been registered and fully described in a report with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files.

IC - Registration No.: 10668A

SHENZHEN TONGCE TESTING LAB

CAB identifier: CN0031

The testing lab has been registered by Innovation, Science and Economic

Development Canada for radio equipment testing.

4.2. Location

SHENZHEN TONGCE TESTING LAB

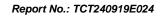
Address: 2101 & 2201, Zhenchang Factory Renshan Industrial Zone, Fuhai Subdistrict, Bao'an District, Shenzhen, Guangdong, 518103, People's Republic of China

TEL: +86-755-27673339

4.3. Measurement Uncertainty

The reported uncertainty of measurement $y \pm U$, where expended uncertainty U is based on a standard uncertainty multiplied by a coverage factor of k=2, providing a level of confidence of approximately 95 %.

No.	Item	MU
1	Conducted Emission	± 3.10 dB
2	RF power, conducted	± 0.12 dB
3	Spurious emissions, conducted	± 0.11 dB
4	All emissions, radiated(<1 GHz)	± 4.56 dB
5	All emissions, radiated(1 GHz - 18 GHz)	± 4.22 dB
6	All emissions, radiated(18 GHz- 40 GHz)	± 4.36 dB





5. Test Results and Measurement Data

5.1. Effective Radiated Power and Effective Isotropic Radiated Power

Measurement

5.1.1. Test Specification

Test Requirement:	Refer to section 2
Test Method:	FCC part 2.1046
Limit:	LTE Band 5: 7W LTE Band 7: 2W LTE Band 41: 2W
Test Setup:	System Simulator
Test Procedure:	 The transmitter output port was connected to the system simulator. Set EUT at maximum power through system simulator. Select lowest, middle, highest channels for each band and different modulation. Measure and record the power level from the system simulator. Calculate the ERP and EIRP The relevant equation for determining the ERP or EIRP from the conducted RF output power measured using the guidance provided above is:

Page 11 of 29

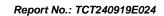


	Koport iton 1012 100 10202
	between the transmitter and the transmitting antenna, this factor can be significant.
Test Result:	PASS

5.1.2. Test Instruments

Equipment	Manufacturer	Model	Serial Number	Calibration Due
Wideband Radio Communication Tester	R&S	CMW500	137557	Jan. 31, 2025
Combiner Box	Ascentest	AT890-RFB	1	1







5.2. Peak to Average Ratio

5.2.1. Test Specification

Test Requirement:	Refer to section 2					
Test Method:	FCC KDB 971168 D01v03					
Limit:	The peak-to-average ratio (PAR) of the transmission may not exceed 13 dB.					
Test Setup:	System Simulator EUT Spectrum Analyzer					
Test Procedure:	 The testing follows FCC KDB 971168 D01v03 Section 5.7.1. The EUT was connected to spectrum analyzer and system simulator via a power divider. Set EUT to transmit at maximum output power. Set the CCDF (Complementary Cumulative Distribution Function) option of the spectrum analyzer. Record the maximum PAPR level associated with a probability of 0.1%. 					
Test Result:	PASS					

5.2.2. Test Instruments

Equipment	Manufacturer	Model	Serial Number	Calibration Due
Wideband Radio Communication Tester	R&S	CMW500	137557	Jan. 31, 2025
Spectrum Analyzer	R&S	FSV40-N	102188	Jan. 31, 2025
Combiner Box	Ascentest	AT890-RFB		(0)



5.3. 99% Occupied Bandwidth and 26dB Bandwidth Measurement

5.3.1. Test Specification

Test Requirement:	Refer to section 2					
Test Method:	FCC part 2.1049					
Limit:	N/A					
Test Setup:	System Simulator Power Divider EUT Spectrum Analyzer					
Test Procedure:	 The testing follows FCC KDB 971168 D01v03 Section 4.2. The EUT was connected to the spectrum analyzer and system simulator via a power divider. The RF output of the EUT was connected to the spectrum analyzer by RF cable and attenuator. The path loss was compensated to the results for each measurement. The 99% occupied bandwidth were measured, set RBW= 1% of OBW, VBW= 3*RBW, sample detector, trace maximum hold. The 26dB bandwidth were measured, set RBW= 1% of EBW, VBW= 3*RBW, peak detector, trace maximum hold. 					
Test Result:	PASS					

5.3.2. Test Instruments

Equipment	Manufacturer	Model	Serial Number	Calibration Due
Wideband Radio Communication Tester	R&S	CMW500	137557	Jan. 31, 2025
Spectrum Analyzer	R&S	FSV40-N	102188	Jan. 31, 2025
Combiner Box	Ascentest	AT890-RFB	1	



5.4. Band Edge and Conducted Spurious Emission Measurement

5.4.1. Test Specification

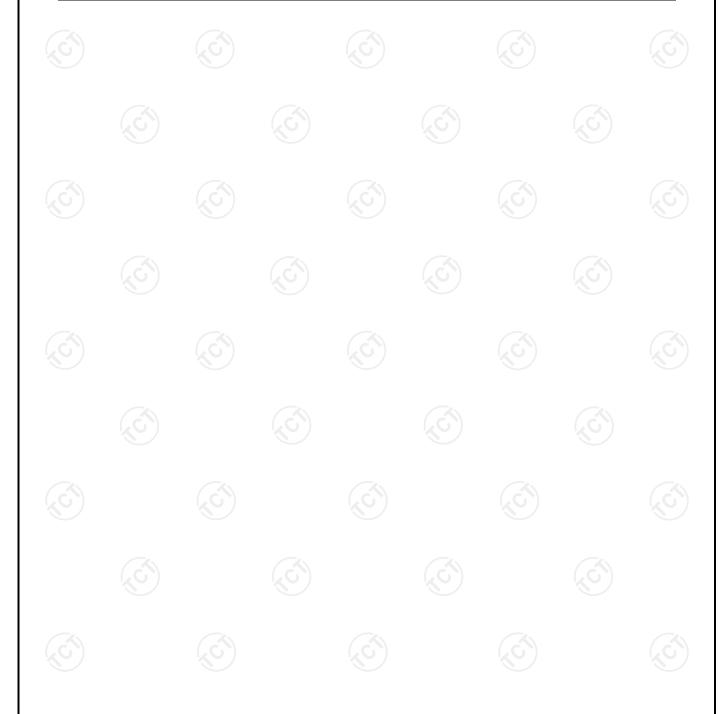
Test Requirement:	Refer to section 2						
Test Method:	FCC part2.1051						
Limit:	-13dbm Band 41: -10dBm/-13dbm/-25dbm						
Test Setup:	System Simulator Power Divider EUT Spectrum Analyzer						
Test Procedure:	 The testing follows FCC KDB 971168 D01v03 Section 6.0. The EUT was connected to the spectrum analyzer and system simulator via a power divider. The RF output of EUT was connected to the spectrum analyzer by an RF cable and attenuator. The path loss was compensated to the results for each measurement. The band edges of low and high channels for the highest RF powers were measured. The conducted spurious emission for the whole frequency range was taken. The RF fundamental frequency should be excluded against the limit line in the operating frequency band. The limit line is derived from 43 + 10log(P) dB below the transmitter power P(Watts) = P(W) - [43 + 10log(P)] (dB) = [30 + 10log(P)] (dBm) - [43 + 10log(P)] (dB) = -13dBm. For Band 17, he limit line is derived from 55 + 10log(P) dB below the transmitter power 						
Test Result:	PASS						

Page 15 of 29



5.4.2. Test Instruments

Equipment	Manufacturer	Model	Serial Number	Calibration Due
Wideband Radio Communication Tester	R&S	CMW500	137557	Jan. 31, 2025
Spectrum Analyzer	R&S	FSV40-N	102188	Jan. 31, 2025
Combiner Box	Ascentest	AT890-RFB	(6) 1	(6)





5.5. Field Strength of Spurious Radiation Measurement

5.5.1. Test Specification

	Test Requirement:	Refer to section 2
/	Test Method:	FCC part 2.1053
	Limit:	For Band 5: -13dBm For Band 7, 41: -25dBm
	Test setup:	4m Measurement Distance Ant Turntable 0.8 or 1.5 m lm RF Test Receiver 4m
		Substitution Ant Sig Gen Ground Plane 1. The testing follows FCC KDB 971168 D01v03 Section 5.8 and ANSI / TIA-603-D-2010Section 2.2.12. 2. The EUT was placed on a rotatable wooden table 0.8 meters above the ground.
	Test Procedure:	 The EUT was set 3 meters from the receiving antenna, which was mounted on the antenna tower. The table was rotated 360 degrees to determine the position of the highest spurious emission. The height of the receiving antenna is varied between one meter and four meters to search for the maximum

T	CT	通测检测
		TESTING CENTRE TECHNOLOGY

Remark:

Report No.: TCT240919E024 spurious emission for both horizontal and vertical polarizations. 6. Make the measurement with the spectrum analyzer's RBW = 1MHz, VBW = 3MHz, taking record of maximum spurious emission. 7. A horn antenna was substituted in place of the EUT and was driven by a signal generator. 8. Tune the output power of signal generator to the same emission level with EUT maximum spurious emission. 9. Taking the record of output power at antenna port. 10. Repeat step 7 to step 8 for another polarization. 11. EIRP (dBm) = S.G. Power - Tx Cable Loss + Tx Antenna Gain 12. ERP (dBm) = EIRP - 2.15 13. The RF fundamental frequency should be excluded against the limit line in the operating frequency band. 14. The limit line is derived from 43 + 10log(P) dB below the transmitter power P(Watts) = P(W) - [43 + 10log(P)] (dB)= [30 + 10log(P)] (dBm) - [43 + 10log(P)] (dB)= -13dBm. Test results: **PASS**

modulation show in this test item.

All modulations have been tested, but only the worst



5.5.2. Test Instruments

	Radiated Em	nission Test Site	e (966)	
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due
Wideband Radio Communication Tester	R&S	CMW500	137557	Jan. 31, 2025
Spectrum Analyzer	R&S	FSQ40	200061	Jun. 26, 2025
Signal Generator	Agilent	N5173B	MY58108823	Jan. 31, 2025
Broadband Antenna	Schwarzbeck	VULB9163	340	Jun. 28, 2025
Horn Antenna	Schwarzbeck	BBHA 9120D	631	Jun. 28, 2025
Broadband Antenna	Schwarzbeck	VULB9163	412	Jun. 28, 2025
Horn Antenna	Schwarzbeck	BBHA 9120D	1201	Jun. 28, 2025
Horn Antenna	Schwarzbeck	BBHA 9170	00956	Feb. 02, 2025
Coaxial cable	SKET	RE-03-D	/	Jun. 26, 2025
Coaxial cable	SKET	RE-03-M	/	Jun. 26, 2025
Coaxial cable	SKET	RE-03-L	1	Jun. 26, 2025
Coaxial cable	SKET	RE-04-D		Jun. 26, 2025
Coaxial cable	SKET	RE-04-M	(2)	Jun. 26, 2025
Coaxial cable	SKET	RE-04-L	/	Jun. 26, 2025
Antenna Mast	Keleto	RE-AM	1	(6)
EMI Test Software	EZ_EMC	FA-03A2 RE+	1.1.4.2	



5.5.3. Test Data

Frequency Range (9 kHz-30MHz)

Frequ	Frequency (MHz)			3m (dBµ	V/m)	Limit@3m (dBµV/m)		
				(. c		(.c)		().

Note: 1. Emission Level=Reading+ Cable loss+Antenna factor-Amp factor

2. The emission levels are 20 dB below the limit value, which are not reported. It is deemed to comply with the requirement



Page 20 of 29

Report No.: TCT240919E024



Band				Test c	hannel:	Lowest
T (1.	Band 9	5(QPSK, 1	OMHz)	Tempe	Temperature :	
Test mode:		•	•		Humidity:	56%
Note: Spuriou	us emissions w	ithin 30-10	00MHz were			ow limit line.
		Spurious	Emission			
Frequency		Level	Correction	Spurious	Limit	Result
(MHz)	Polarization	(dBm)	Factor	emissions	(dBm)	Nesuit
			(dB)	(dBm)		
1658.00	Vertical	-42.13	-6.46	-48.59		/
2487.00	V	-46.11	-2.84	-48.95		
3316.00	V	-60.72	-0.48	-61.20	-13.00	PASS
1658.00	Horizontal	-41.19	-6.30	-47.49	-13.00	PASS
2487.00	H	-42.10	-2.95	-45.05		
3316.00	H	-59.49	-0.10	-59.59		
Band				Test c	hannel:	Middle
Tost mode	Band 9	5(QPSK, 1	OMHz)	Tempe	erature :	25°C
Test mode:				Relative	Humidity:	56%
Note: Spuriou	us emissions w	ithin 30-10	00MHz were	found more t	han 20dB bel	ow limit line.
		Spurious	Emission			
Frequency		Lovel	Correction	Spurious	Limit	Result
(MHz)	Polarization	Level	Factor	emissions	(dBm)	
, ,		(dBm)	(dB)	(dBm)	, ,	
1673.00	Vertical	-40.17	-6.46	-46.63		
2509.50	V	-52.95	-2.75	-55.70	(,c	
3346.00	/ V	-58.98	-0.47	-59.45	40.00	DAGG
1673.00	Horizontal	-39.13	-6.32	-45.45	-13.00	PASS
2509.50	Н	-45.04	-2.86	-47.90		
3346.00	H. C	-59.81	-0.10	-59.91		(.c.)
Band			,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,	Test c	hannel:	Highest
T (l.	Band 9	5(QPSK, 1	OMHz)		erature :	25°C
Test mode:		•	•		Humidity:	56%
Note: Spuriou	us emissions w	ithin 30-10	00MHz were	found more t	han 20dB bel	ow limit line.
		Spurious	Emission			
Frequency		l aval	Correction	Spurious	Limit	Dogult
(MHz)	Polarization	Level	Factor	emissions	(dBm)	Result
, ,		(dBm)	(dB)	(dBm)	, ,	
1688.00	Vertical	-44.49	-6.45	-50.94		
2532.00	V	-53.25	-2.65	-55.90		
3376.00	V	-64.82	-0.47	-65.29	40.00	DA 00
1688.00	Horizontal	-39.01	-6.34	-45.35	-13.00	PASS
2532.00	/ H	-49.06	-2.74	-51.80		/
2002.00						



Band				Test o	hannel:	Lowest
Tool woods	Band 5	(16QAM, ²	10MHz)	Tempe	erature :	25°C
Test mode:		•	•		Humidity:	56%
Note: Spuriou	us emissions w	ithin 30-10	00MHz were			low limit line.
		Spurious	Emission			
Frequency		Level	Correction	Spurious	Limit	Result
(MHz)	Polarization	(dBm)	Factor	emissions	(dBm)	Nesuit
		(ubiii)	(dB)	(dBm)		
1658.00	Vertical	-39.53	-6.46	-45.99		
2487.00	V	-46.04	-2.84	-48.88		
3316.00	V	-60.61	-0.48	-61.09	-13.00	PASS
1658.00	Horizontal	-39.59	-6.30	-45.89	-13.00	PASS
2487.00	Н	-46.46	-2.95	-49.41		
3316.00	Н	-59.27	-0.10	-59.37		
Band				Test o	hannel:	Middle
Toot mode.	Band 5	(16QAM, 1	10MHz)	Tempe	erature :	25°C
Test mode:				Relative	Humidity:	56%
Note: Spuriou	us emissions w	ithin 30-10	00MHz were	found more t	han 20dB bel	low limit line.
		Spurious	Emission			
Frequency		l avval	Correction	Spurious	Limit	Daguille
(MHz)	Polarization	Level	Factor	emissions	(dBm)	Result
,		(dBm)	(dB)	(dBm)	, ,	
1673.00	Vertical	-40.65	-6.46	-47.11		
2509.50	V	-52.68	-2.75	-55.43	(.ć	
3346.00	/ V	-59.02	-0.47	-59.49	40.00	DACC
1673.00	Horizontal	-36.80	-6.32	-43.12	-13.00	PASS
2509.50	Н	-47.33	-2.86	-50.19		
3346.00	H.C	-59.81	-0.10	-59.91		
Band			1,2 (3)	Test o	hannel:	Highest
- .	Band 5	(16QAM, ²	10MHz)		erature :	25°C
Test mode:		,	,		Humidity:	56%
Note: Spuriou	us emissions w	ithin 30-10	00MHz were	found more t	han 20dB bel	low limit line.
•			Emission			
Frequency			Correction	Spurious	Limit	D II
(MHz)	Polarization	Level	Factor	emissions	(dBm)	Result
,		(dBm)	(dB)	(dBm)	,	
1688.00	Vertical	-43.75	-6.45	-50.20		
2532.00	V	-51.88	-2.65	-54.53		
3376.00	V	-60.70	-0.47	-61.17	40.00	DA 00
1688.00	Horizontal	-40.04	-6.34	-46.38	-13.00	PASS
2532.00	H	-49.11	-2.74	-51.85		
3376.00	Н	-63.12	-0.10	-63.22		
337 3.00		55.12	00	30.22	I	



Band				Test c	hannel:	Lowest
	Band :	7(QPSK, 2	OMHz)		erature :	25°C
Test mode:		(· · · · · · · · · · · · · · · · · · ·		Humidity:	56%
Note: Spuriou	us emissions w	ithin 30-10	00MHz were			
•			Emission			
Frequency			Correction	Spurious	Limit	Danielt
(MHz)	Polarization	Level	Factor	emissions	(dBm)	Result
,		(dBm)	(dB)	(dBm)	,	
5020.00	Vertical	-43.02	5.93	-37.09		
7530.00	V	-46.31	10.45	-35.86		
10040.00	V	-62.03	14.82	-47.21	05.00	DA 00
5020.00	Horizontal	-41.39	6.33	-35.06	-25.00	PASS
7530.00	H	-44.02	10.06	-33.96		
10040.00	Н	-57.80	14.48	-43.32		
Band				Test c	hannel:	Middle
Took mode.	Band 1	7(QPSK, 2	OMHz)	Tempe	erature :	25°C
Test mode:		•	·	Relative	Humidity:	56%
Note: Spuriou	us emissions w	ithin 30-10	00MHz were	found more t	han 20dB bel	low limit line.
•			Emission			
Frequency		Lovel	Correction	Spurious	Limit	Dogult
(MHz)	Polarization	Level	Factor	emissions	(dBm)	Result
		(dBm)	(dB)	(dBm)		
5070.00	Vertical	-39.99	6.01	-33.98		·
7605.00	V	-51.82	10.54	-41.28	(,c	
10140.00	/ V	-60.25	14.88	-45.37	-25.00	PASS
5070.00	Horizontal	-37.78	6.42	-31.36	-25.00	FASS
7605.00	H	-46.03	10.24	-35.79		
10140.00	H.C	-59.81	14.65	-45.16	(6)	(C)
Band				Test c	hannel:	Highest
Toot model	Band 1	7(QPSK, 2	0MHz)	Tempe	erature :	25°C
Test mode:				Relative	Humidity:	56%
Note: Spuriou	us emissions w			found more t	han 20dB bel	ow limit line.
		Spurious	Emission			
Frequency		Level	Correction	Spurious	Limit	Result
(MHz)	Polarization	(dBm)	Factor	emissions	(dBm)	Result
		(ubiii)	(dB)	(dBm)		
5120.00	Vertical	-42.84	6.09	-36.75		
7680.00	V	-52.78	10.63	-42.15		
10240.00	V	-66.22	14.95	-51.27	-25.00	PASS
5120.00	Horizontal	-39.73	6.52	-33.21	-25.00	FASS
7680.00	/ H	-48.91	10.43	-38.48		
10240.00	Н	-63.08	14.82	-48.26		



Band				Test c	hannel:	Lowest
_ , .	Band 7	(16QAM, ⁻	10MHz)		erature :	25°C
Test mode:		, . ,	,		Humidity:	56%
Note: Spuriou	us emissions w	ithin 30-10	00MHz were			
			Emission			
Frequency		l avval	Correction	Spurious	Limit	Dogult
(MHz)	Polarization	Level	Factor	emissions	(dBm)	Result
, ,		(dBm)	(dB)	(dBm)	, ,	
5020.00	Vertical	-40.73	5.93	-34.80		
7530.00	V	-44.58	10.45	-34.13		
10040.00	V	-62.51	14.82	-47.69	25.00	DA CC-
5020.00	Horizontal	-41.49	6.33	-35.16	-25.00	PASS
7530.00	Н	-44.92	10.06	-34.86		
10040.00	Н	-59.10	14.48	-44.62		
Band				Test c	hannel:	Middle
Toot mode:	Band 7	(16QAM, [*]	10MHz)	Tempe	erature :	25°C
Test mode:		•	,	Relative	Humidity:	56%
Note: Spuriou	us emissions w	ithin 30-10	00MHz were	found more t	han 20dB bel	low limit line.
			Emission			
Frequency			Correction	Spurious	Limit	Desult
(MHz)	Polarization	Level	Factor	emissions	(dBm)	Result
, ,		(dBm)	(dB)	(dBm)		
5070.00	Vertical	-40.47	6.01	-34.46		· .
7605.00	V	-52.05	10.54	-41.51	(.ć	
10140.00	V	-61.88	14.88	-47.00	25.00	DACC
5070.00	Horizontal	-38.06	6.42	-31.64	-25.00	PASS
7605.00	H	-47.11	10.24	-36.87		
10140.00	H. C	-60.12	14.65	-45.47	(G)	(.c)
Band				Test c	hannel:	Highest
Tables de	Band 7	(16QAM, [*]	10MHz)	Tempe	erature :	25°C
Test mode:		•	•	Relative	Humidity:	56%
Note: Spuriou	us emissions w	ithin 30-10	00MHz were	found more t	han 20dB bel	low limit line.
<u> </u>		Spurious	Emission			
Frequency		•	Correction	Spurious	Limit	Descrit
(MHz)	Polarization	Level	Factor	emissions	(dBm)	Result
, ,		(dBm)	(dB)	(dBm)	, ,	
5120.00	Vertical	-43.39	6.09	-37.30		
7680.00	V	-50.54	10.63	-39.91		
10240.00	V	-60.16	14.95	-45.21	05.00	DACC
5120.00	Horizontal	-38.38	6.52	-31.86	-25.00	PASS
	Н	-48.62	10.43	-38.19		
7680.00					1	



Band				Test c	hannel:	Lowest
- , ,	Band 4	1(QPSK, 2	20MHz)		erature:	25°C
Test mode:		(, - ,	,		Humidity:	56%
Note: Spuriou	us emissions w	ithin 30-10	00MHz were			
			Emission			
Frequency		l avval	Correction	Spurious	Limit	Dogult
(MHz)	Polarization	Level	Factor	emissions	(dBm)	Result
, ,		(dBm)	(dB)	(dBm)	, ,	
5012.00	Vertical	-42.13	5.92	-36.21		
7518.00	V	-47.91	10.43	-37.48		
10024.00	V	-62.32	14.81	-47.51	25.00	DA CC-
5012.00	Horizontal	-42.69	6.31	-36.38	-25.00	PASS
7518.00	Н	-44.56	10.03	-34.53		
10024.00	Н	-61.24	14.45	-46.79		
Band				Test c	hannel:	Middle
Toot made:	Band 4	1(QPSK, 2	20MHz)	Temp	erature:	25°C
Test mode:			-	Relative	Humidity:	56%
Note: Spuriou	us emissions w	ithin 30-10	00MHz were	found more t	han 20dB bel	low limit line.
		Spurious	Emission			
Frequency		Level	Correction	Spurious	Limit	Result
(MHz)	Polarization		Factor	emissions	(dBm)	Result
		(dBm)	(dB)	(dBm)		
5186.00	Vertical	-43.38	6.19	-37.19		
7779.00	V	-52.43	10.74	-41.69	(,c	
10372.00	/ V	-63.26	15.04	-48.22	-25.00	PASS
5186.00	Horizontal	-38.81	6.64	-32.17	-25.00	PASS
7779.00	H	-44.80	10.68	-34.12		
10372.00	H.C	-61.09	15.04	-46.05	(C)	(C)
Band				Test c	hannel:	Highest
Toot made:	Band 4	1(QPSK, 2	20MHz)	Temp	erature:	25°C
Test mode:		•	•	Relative	Humidity:	56%
Note: Spuriou	us emissions w	ithin 30-10	00MHz were	found more t	han 20dB bel	low limit line.
		Spurious	Emission			
Frequency		Level	Correction	Spurious	Limit	Result
(MHz)	Polarization		Factor	emissions	(dBm)	Result
		(dBm)	(dB)	(dBm)		
5360.00	Vertical	-43.95	6.46	-37.49		
8040.00	V	-53.47	11.15	-42.32		
10720.00	V	-65.26	15.28	-49.98	-25.00	PASS
5360.00	Horizontal	-39.47	6.97	-32.50	-25.00	FASS
8040.00	/ H	-47.93	11.37	-36.56		
10720.00	Н	-65.02	15.63	-49.39		



Band	Test		Test c	hannel:	Lowest		
	Band 41(16QAM, 10MHz)				Temperature:		
Test mode:					Relative Humidity:		
Note: Spuriou	us emissions w	ithin 30-10	00MHz were			56% low limit line.	
<u> </u>	Spurious Emission						
Frequency		Lovel	Correction	Spurious	Limit	Result	
(MHz)	Polarization	Level	Factor	emissions	(dBm)	Result	
		(dBm)	(dB)	(dBm)			
5012.00	Vertical	-42.33	5.92	-36.41		/	
7518.00	V	-45.59	10.43	-35.16			
10024.00	V	-63.64	14.81	-48.83	25.00	PASS	
5012.00	Horizontal	-40.31	6.31	-34.00	-25.00	PASS	
7518.00	Н	-46.92	10.03	-36.89			
10024.00	Н	-60.58	14.45	-46.13			
Band					hannel:	Middle	
Test mode:	Band 41(16QAM, 10MHz)			Temp	erature:	25°C	
rest mode:				Relative	Humidity:	56%	
Note: Spuriou	us emissions w	ithin 30-10	00MHz were	found more t	han 20dB be	low limit line.	
		Spurious	Emission				
Frequency		Lovel	Correction	Spurious	Limit	Result	
(MHz)	Polarization	Level	Factor	emissions	(dBm)	Result	
		(dBm)	(dB)	(dBm)			
5186.00	Vertical	-41.67	6.19	-35.48		PASS	
7779.00	V	-51.94	10.74	-41.20	(.c		
10372.00	/ V	-61.08	15.04	-46.04	-25.00		
5186.00	Horizontal	-40.26	6.64	-33.62	-25.00		
7779.00	H	-48.19	10.68	-37.51			
10372.00	H.C	-60.73	15.04	-45.69	(C)	(C)	
Band				Test c	hannel:	Highest	
Toot mode.	Band 41(16QAM, 10MHz)			Temp	erature:	25°C	
Test mode:			Humidity:	56%			
Note: Spuriou	us emissions w	ithin 30-10	00MHz were	found more t	han 20dB be	low limit line.	
		Spurious					
Frequency	Polarization	Level (dBm)	Correction	Spurious	Limit (dBm)	Result	
(MHz)			Factor	emissions		Nesuit	
			(dB)	(dBm)			
5360.00	Vertical	-43.42	6.46	-36.96		PASS	
8040.00	V	-52.71	11.15	-41.56			
10720.00	V	-61.04	15.28	-45.76	-25.00		
5360.00	Horizontal	-40.18	6.97	-33.21	-25.00		
8040.00	/ H	-48.20	11.37	-36.83			
10720.00	Н	-63.75	15.63	-48.12			



5.6. Frequency Stability Measurement

5.6.1. Test Specification

for at least half an hour. Power was applied and the maximum frequency change was recorded within one minute. Test Procedures for Voltage Variation 1. The testing follows FCC KDB 971168 D01v03 Section 9.0. 2. The EUT was placed in a temperature chamber at 25±5° C and connected with the system simulator. 3. The power supply voltage to the EUT was varied from BEP to 115% of the nominal value measured at the input to the EUT. 4. The variation in frequency was measured for the worst case. 5. The worst case(worst bandwidth) for frequency stability reported in the Test Data. The worst bandwidth is as follow: 1.4M is for LTE Band 2, 1.4M is for LTE Band 4, 1.4M is for LTE Band 12, 5M is for LTE Band 13, 5M is for LTE Band 17, 1.4M is for LTE Band 25, 1.4M is for LTE Band 26-1, 1.4M is for LTE Band 26-2, 5M is for LTE Band 41, 1.4M is for LTE Band 66	Test Requirement:	FCC part 27.54, FCC part 22.355, 24.235				
Test Procedures for Temperature Variation 1. The testing follows FCC KDB 971168 D01v03 Section 9.0. 2. The EUT was set up in the thermal chamber and connected with the system simulator. 3. With power OFF, the temperature was decreased to -30°C and the EUT was stabilized before testing. Power was applied and the maximum change in frequency was recorded within one minute. 4. With power OFF, the temperature was raised in 10°C steps up to 50°C. The EUT was stabilized at each step for at least half an hour. Power was applied and the maximum frequency change was recorded within one minute. Test Procedures for Voltage Variation 1. The testing follows FCC KDB 971168 D01v03 Section 9.0. 2. The EUT was placed in a temperature chamber at 25±5°C and connected with the system simulator. 3. The power supply voltage to the EUT was varied from BEP to 115% of the nominal value measured at the input to the EUT. 4. The variation in frequency was measured for the worst case. 5. The worst case(worst bandwidth) for frequency stability reported in the Test Data. The worst bandwidth is as follow: 1.4M is for LTE Band 2, 1.4M is for LTE Band 4, 1.4M is for LTE Band 12, 5M is for LTE Band 25, 1.4M is for LTE Band 25, 1.4M is for LTE Band 26-1, 1.4M is for LTE Band 25, 1.4M is for LTE Band 26-2, 5M is for LTE Band 26-2, 5M is for LTE Band 66	Test Method:					
Test Procedures Test Procedures for Temperature Variation 1. The testing follows FCC KDB 971168 D01v03 Section 9.0. 2. The EUT was set up in the thermal chamber and connected with the system simulator. 3. With power OFF, the temperature was decreased to -30°C and the EUT was stabilized before testing. Power was applied and the maximum change in frequency was recorded within one minute. 4. With power OFF, the temperature was raised in 10°C steps up to 50°C. The EUT was stabilized at each step for at least half an hour. Power was applied and the maximum frequency change was recorded within one minute. Test Procedures for Voltage Variation 1. The testing follows FCC KDB 971168 D01v03 Section 9.0. 2. The EUT was placed in a temperature chamber at 25±5°C and connected with the system simulator. 3. The power supply voltage to the EUT was varied from BEP to 115% of the nominal value measured at the input to the EUT. 4. The variation in frequency was measured for the worst case. 5. The worst case(worst bandwidth) for frequency stability reported in the Test Data. The worst bandwidth is as follow: 1.4M is for LTE Band 2, 1.4M is for LTE Band 4, 1.4M is for LTE Band 12, 5M is for LTE Band 25, 3. M is for LTE Band 17, 1.4M is for LTE Band 25, 1.4M is for LTE Band 26-1, 1.4M is for LTE Band 26-2, 5M is for LTE Band 41, 1.4M is for LTE Band 26-2, 5M is for LTE Band 41, 1.4M is for LTE Band 26-2,	Limit:	±2.5 ppm				
1. The testing follows FCC KDB 971168 D01v03 Section 9.0. 2. The EUT was set up in the thermal chamber and connected with the system simulator. 3. With power OFF, the temperature was decreased to -30°C and the EUT was stabilized before testing. Power was applied and the maximum change in frequency was recorded within one minute. 4. With power OFF, the temperature was raised in 10°C steps up to 50°C. The EUT was stabilized at each step for at least half an hour. Power was applied and the maximum frequency change was recorded within one minute. Test Procedures for Voltage Variation 1. The testing follows FCC KDB 971168 D01v03 Section 9.0. 2. The EUT was placed in a temperature chamber at 25±5°C and connected with the system simulator. 3. The power supply voltage to the EUT was varied from BEP to 115% of the nominal value measured at the input to the EUT. 4. The variation in frequency was measured for the worst case. 5. The worst case(worst bandwidth) for frequency stability reported in the Test Data. The worst bandwidth is as follow: 1.4M is for LTE Band 2, 1.4M is for LTE Band 4, 1.4M is for LTE Band 12, 5M is for LTE Band 7, 1.4M is for LTE Band 17, 1.4M is for LTE Band 25, 1.4M is for LTE Band 17, 1.4M is for LTE Band 25, 1.4M is for LTE Band 26-1, 1.4M is for LTE Band 26-2, 5M is for LTE Band 41, 1.4M is for LTE Band 26-2, 5M is for LTE Band 41, 1.4M is for LTE Band 26-2, 5M is for LTE Band 41, 1.4M is for LTE Band 66	Test Setup:	System Simulator				
Took Doorelle	Test Procedure:	 The testing follows FCC KDB 971168 D01v03 Section 9.0. The EUT was set up in the thermal chamber and connected with the system simulator. With power OFF, the temperature was decreased to -30°C and the EUT was stabilized before testing. Power was applied and the maximum change in frequency was recorded within one minute. With power OFF, the temperature was raised in 10°C steps up to 50°C. The EUT was stabilized at each step for at least half an hour. Power was applied and the maximum frequency change was recorded within one minute. Test Procedures for Voltage Variation The testing follows FCC KDB 971168 D01v03 Section 9.0. The EUT was placed in a temperature chamber at 25±5° C and connected with the system simulator. The power supply voltage to the EUT was varied from BEP to 115% of the nominal value measured at the input to the EUT. The variation in frequency was measured for the worst case. The worst case(worst bandwidth) for frequency stability reported in the Test Data. The worst bandwidth is as follow: 1.4M is for LTE Band 2, 1.4M is for LTE Band 4, 1.4M is for LTE Band 17, 1.4M is for LTE Band 25, 1.4M is for LTE Band 17, 1.4M is for LTE Band 25, 1.4M is for LTE Band 26-1, 1.4M is for LTE Band 26-2, 1.4M is for LTE Ba				



5.6.2. Test Instruments

Equipment	Manufacturer	Model	Serial Number	Calibration Due
Wideband Radio Communication Tester	R&S	CMW500	137557	Jan. 31, 2025
Programable tempratuce and humidity chamber	JQ	JQ-2000		Jun. 26, 2025
DC power supply	Kingrang	KR3005K	/	Jun. 26, 2025
Combiner Box	AT890-RFB	Ascentest	1 (3)	1 6





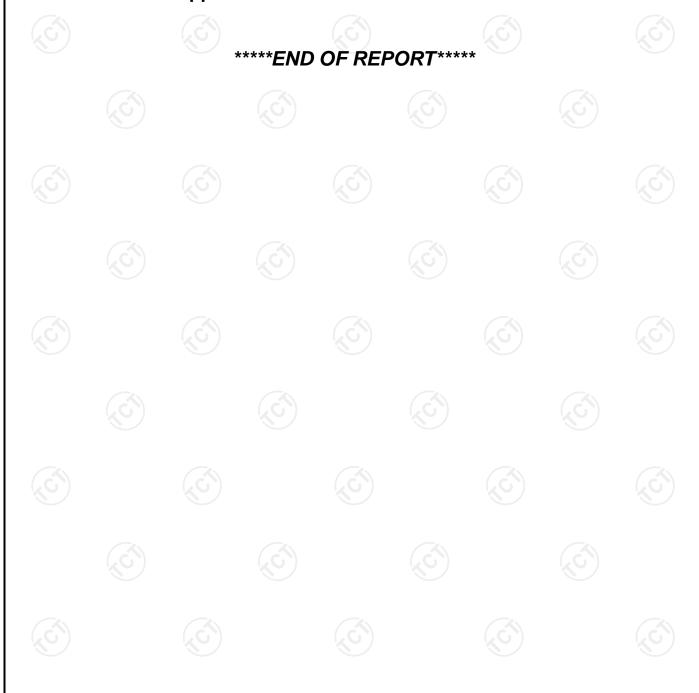
Appendix B: Photographs of Test Setup

Please refer to document Appendix No.: TCT240919E022-A

Appendix C: Photographs of EUT

Please refer to document Appendix No.: TCT240919E022-B & TCT240919E022-C

Test Data for Appendix Refer to Appendix For LTE Band 5, Appendix For LTE Band 7 and Appendix For LTE Band 41



Page 29 of 29